


<b>Search Notes</b> 	<b>Application/Control No.</b> 10629034	<b>Applicant(s)/Patent Under Reexamination</b> ZALESKI, JOHN R.
	<b>Examiner</b> Nguyen, Tran N	<b>Art Unit</b> 3626

SEARCHED			
Class	Subclass	Date	Examiner
705	2	2/8/2008	/TN/

SEARCH NOTES		
Search Notes	Date	Examiner
705/2-3 and restriction requirements (consulted C. Gilligan, GAU 3626)	11/29/2007	/TN/
Continuity search (PALM)	2/8/2008	/TN/
Inventor search (PALM)	2/8/2008	/TN/
US patents (EAST)	2/8/2008	/TN/
NPL (Google/Google Scholar)	2/8/2008	/TN/
705/2 Dialog mandatory databases (149, 444, 5, 73, 155, 34, 434, 455, 129, 130, 74, 42)	2/8/2008	/TN/
Restriction requirements (consulted C. Gilligan, GAU 3626)	8/1/2008	/TN/
101 (consulted R. Weinhardt)	8/12/2008	/TN/
NPL (Google/Google Scholar)	8/12/2008	/TN/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/T. N./  
Examiner, Art Unit 3626